

<b>Notice of References Cited</b>	Application/Control No. 10/624,403		Applicant(s)/Patent Under Reexamination FU ET AL.	
	Examiner SHIN-HON CHEN		Art Unit 2431	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,068,786	06-2006	Graunke et al.	380/44
*	B	US-5,875,247	02-1999	Nakashima et al.	705/52
	C	US-			
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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